## 国際会議 2013 年度

● [08] 2014/02/06@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

Evaluation of the MRR control performance of PCVM with the application of the PWM control OY. Takeda, Y. Hata, J. Ito, K. Endo, K. Yamamura

● [07] 2014/02/06@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

Optimization of water content in process gas for high MRR of single crystal diamond in plasma assisted polishing

OT. Tabata, K. Monna, Y. Yamamoto, S. Makiyama, H. Deng, K. Endo, K. Yamamura

[06] 2014/02/06@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

Development of two-stage figuring process applying numerically controlled electrochemical machining for fabricating neutron focusing mirror substrate

ON. Mitsushima, M. Ouchi, K. Endo, K. Yamamura

[05] 2014/02/06@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

Effects of water concentration and gas species on OH radical emission intensity in plasma assisted polishing

OK. Monna, H. Deng, T. Tabata, K. Endo, K. Yamamura

• [04] 2014/02/06@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

XTEM observation of the anodic oxide layer/SiC interface morphology during anodic oxidation assisted polishing

OK. Hosoya, Y. Imanishi, K. Endo, K. Yamamura

• [03] 2014/02/06@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

Nanoindentation studies on the mechanical properties of silicon face and carbon face of 4H-SiC OH. Deng, K. Endo, K. Yamamura

[02] 2014/02/06@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

Profile measurement of aspheric mirror using High-Speed Nanoprofiler

OK. Okuda, K. Usuki, T. Kitayama, T. Kojima, K. Okita, R. Tokura, M. Nakano, <u>R. Kudo, K. Yamamura,</u> K. Endo

● [01] 2014/02/05@Osaka in Japan

International Workshop on Atomically Controlled Fabrication Technology

Development of precisely controlled metallodielectric plasmonic nanoshell arrays with nanogap for sensitive detection of molecular adsorption based on NIR responsive LSPR

OS. Uchida, N. Zettsu, K. Yamamura, K. Endo